

### General Description

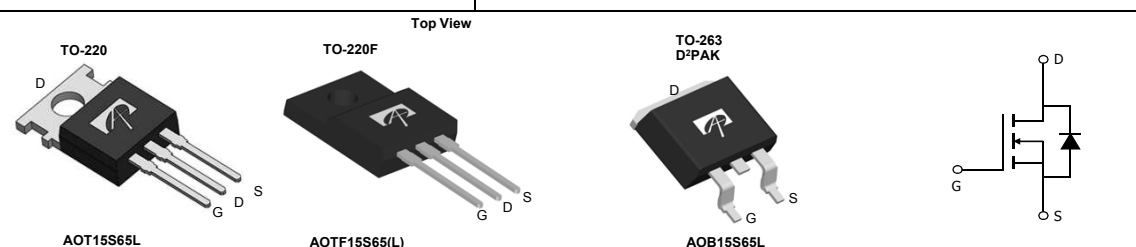
The AOT15S65L & AOB15S65L & AOTF15S65L & AOTF15S65 have been fabricated using the advanced  $\alpha$ MOS™ high voltage process that is designed to deliver high levels of performance and robustness in switching applications.

By providing low  $R_{DS(on)}$ ,  $Q_g$  and  $E_{OSS}$  along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

### Product Summary

|                      |               |
|----------------------|---------------|
| $V_{DS} @ T_{j,max}$ | 750V          |
| $I_{DM}$             | 60A           |
| $R_{DS(on),max}$     | 0.29 $\Omega$ |
| $Q_{g,typ}$          | 17.2nC        |
| $E_{OSS} @ 400V$     | 3.6 $\mu$ J   |

100% UIS Tested  
100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                                                                 | Symbol                            | AOT15S65L/AOB15S65L | AOTF15S65 | AOTF15S65L | Units |
|-------------------------------------------------------------------------------------------|-----------------------------------|---------------------|-----------|------------|-------|
| Drain-Source Voltage                                                                      | V <sub>DS</sub>                   | 650                 |           |            | V     |
| Gate-Source Voltage                                                                       | V <sub>GS</sub>                   | ±30                 |           |            | V     |
| Continuous Drain Current                                                                  | I <sub>D</sub>                    | 15                  | 15*       | 15*        | A     |
| Current                                                                                   |                                   | 10                  | 10*       | 10*        |       |
| Pulsed Drain Current <sup>C</sup>                                                         | I <sub>DM</sub>                   | 60                  |           |            |       |
| Avalanche Current <sup>C</sup>                                                            | I <sub>AR</sub>                   | 2.4                 |           |            | A     |
| Repetitive avalanche energy <sup>C</sup>                                                  | E <sub>AR</sub>                   | 86                  |           |            | mJ    |
| Single pulsed avalanche energy <sup>G</sup>                                               | E <sub>AS</sub>                   | 173                 |           |            | mJ    |
| Power Dissipation <sup>B</sup>                                                            | T <sub>C</sub> =25°C              | 208                 | 50        | 34         | W     |
|                                                                                           | Derate above 25°C                 | 1.7                 | 0.4       | 0.3        | W/ °C |
| MOSFET dv/dt ruggedness                                                                   | dv/dt                             | 100                 |           |            | V/ns  |
| Peak diode recovery dv/dt <sup>H</sup>                                                    |                                   | 20                  |           |            |       |
| Junction and Storage Temperature Range                                                    | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150          |           |            | °C    |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds <sup>J</sup> | T <sub>L</sub>                    | 300                 |           |            | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol          | AOT15S65L/AOB15S65L | AOTF15S65 | AOTF15S65L | Units              |
|--------------------------------------------|-----------------|---------------------|-----------|------------|--------------------|
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 65                  | 65        | 65         | $^\circ\text{C/W}$ |
| Maximum Case-to-sink <sup>A</sup>          | $R_{\theta CS}$ | 0.5                 | --        | --         | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 0.6                 | 2.5       | 3.7        | $^\circ\text{C/W}$ |

\* Drain current limited by maximum junction temperature.

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                                                 | Conditions                                                                             | Min | Typ   | Max  | Units |
|-----------------------------|-----------------------------------------------------------|----------------------------------------------------------------------------------------|-----|-------|------|-------|
| <b>STATIC PARAMETERS</b>    |                                                           |                                                                                        |     |       |      |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                            | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                       | 650 | -     | -    | V     |
|                             |                                                           | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C                      | 700 | 750   | -    |       |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                           | V <sub>DS</sub> =650V, V <sub>GS</sub> =0V                                             | -   | -     | 1    | μA    |
|                             |                                                           | V <sub>DS</sub> =520V, T <sub>J</sub> =150°C                                           | -   | 10    | -    |       |
| I <sub>GSS</sub>            | Gate-Body leakage current                                 | V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V                                             | -   | -     | ±100 | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                                    | V <sub>DS</sub> =5V, I <sub>D</sub> =250μA                                             | 2.6 | 3.3   | 4    | V     |
| R <sub>DS(on)</sub>         | Static Drain-Source On-Resistance                         | V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A, T <sub>J</sub> =25°C                       | -   | 0.254 | 0.29 | Ω     |
|                             |                                                           | V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A, T <sub>J</sub> =150°C                      | -   | 0.68  | 0.78 | Ω     |
| V <sub>SD</sub>             | Diode Forward Voltage                                     | I <sub>S</sub> =7.5A, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                        | -   | 0.82  | -    | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current                     |                                                                                        | -   | -     | 15   | A     |
| I <sub>SM</sub>             | Maximum Body-Diode Pulsed Current <sup>C</sup>            |                                                                                        | -   | -     | 60   | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                                           |                                                                                        |     |       |      |       |
| C <sub>iss</sub>            | Input Capacitance                                         | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz                                     | -   | 841   | -    | pF    |
| C <sub>oss</sub>            | Output Capacitance                                        |                                                                                        | -   | 58    | -    | pF    |
| C <sub>o(er)</sub>          | Effective output capacitance, energy related <sup>H</sup> | V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 480V, f=1MHz                                | -   | 40    | -    | pF    |
| C <sub>o(tr)</sub>          | Effective output capacitance, time related <sup>I</sup>   |                                                                                        | -   | 150   | -    | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                              | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz                                     | -   | 1.1   | -    | pF    |
| R <sub>g</sub>              | Gate resistance                                           | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                       | -   | 14    | -    | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                                           |                                                                                        |     |       |      |       |
| Q <sub>g</sub>              | Total Gate Charge                                         | V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =7.5A                      | -   | 17.2  | -    | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                        |                                                                                        | -   | 4.3   | -    | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                         |                                                                                        | -   | 5.6   | -    | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                         | V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =7.5A, R <sub>G</sub> =25Ω | -   | 27    | -    | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                         |                                                                                        | -   | 24    | -    | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                        |                                                                                        | -   | 90    | -    | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                        |                                                                                        | -   | 23    | -    | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                          | I <sub>F</sub> =7.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                             | -   | 320   | -    | ns    |
| I <sub>rm</sub>             | Peak Reverse Recovery Current                             | I <sub>F</sub> =7.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                             | -   | 27    | -    | A     |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                        | I <sub>F</sub> =7.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                             | -   | 5.5   | -    | μC    |

A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25° C.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. L=60mH, I<sub>AS</sub>=2.4A, V<sub>DD</sub>=150V, Starting T<sub>J</sub>=25° C

H. C<sub>o(er)</sub> is a fixed capacitance that gives the same stored energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

I. C<sub>o(tr)</sub> is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

J. Wavesoldering only allowed at leads.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

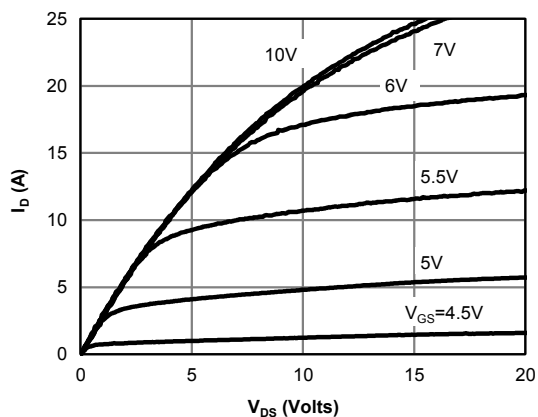


Figure 1: On-Region Characteristics@25° C

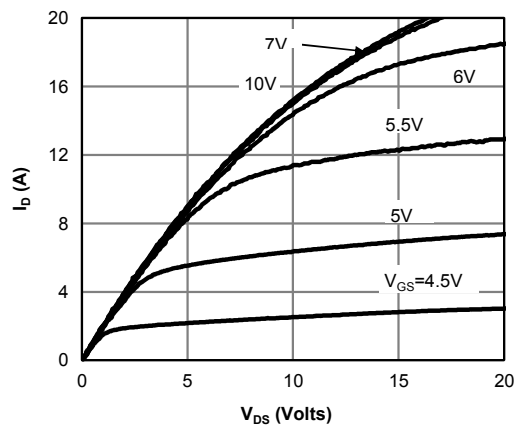


Figure 2: On-Region Characteristics@125° C

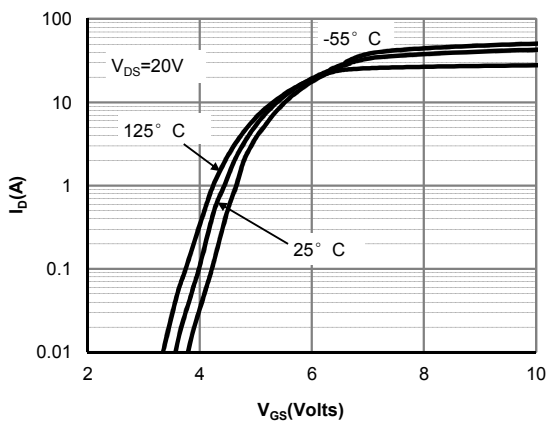


Figure 3: Transfer Characteristics

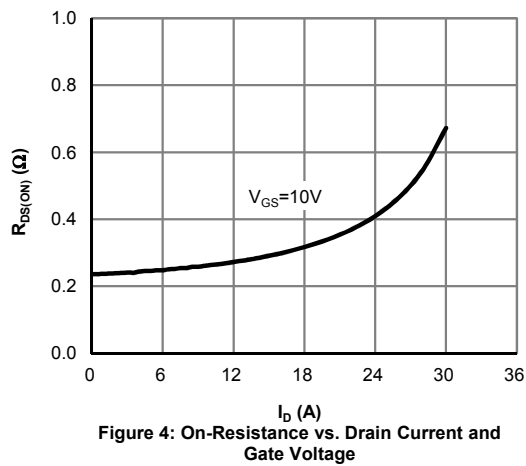


Figure 4: On-Resistance vs. Drain Current and Gate Voltage

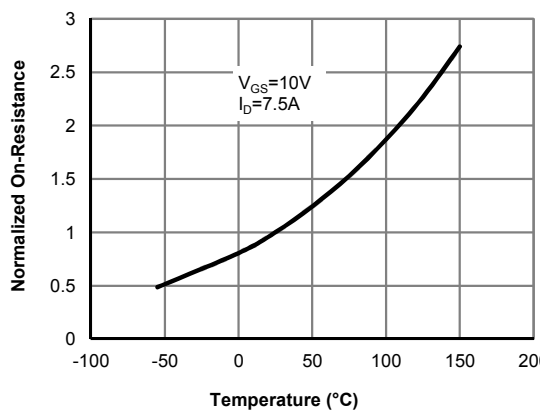


Figure 5: On-Resistance vs. Junction Temperature

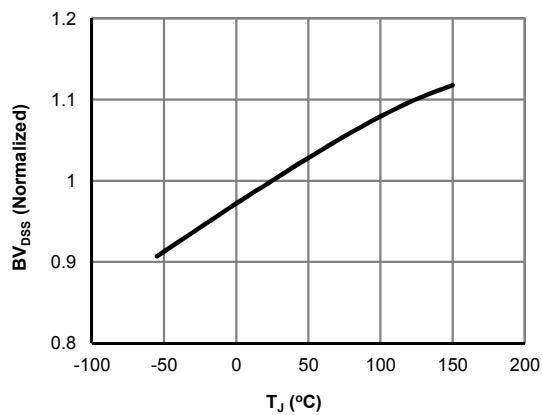


Figure 6: Break Down vs. Junction Temperature



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

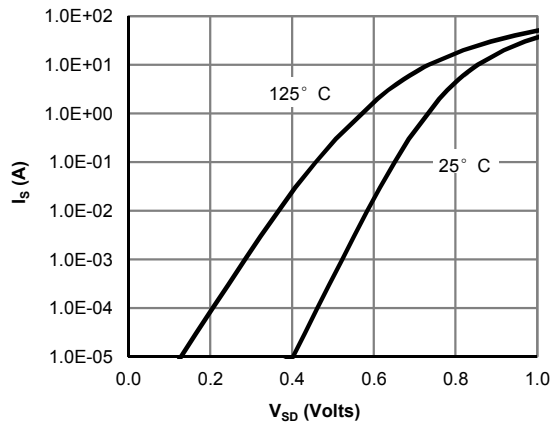


Figure 7: Body-Diode Characteristics (Note E)

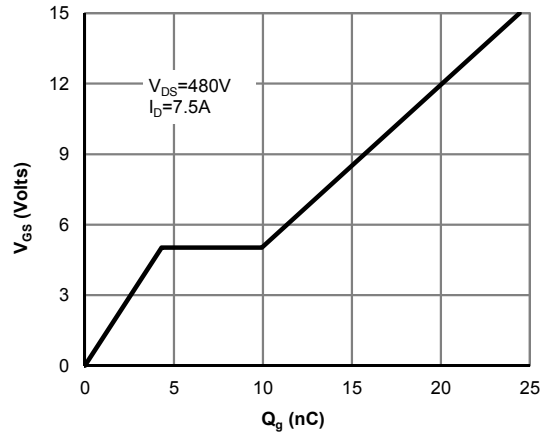


Figure 8: Gate-Charge Characteristics

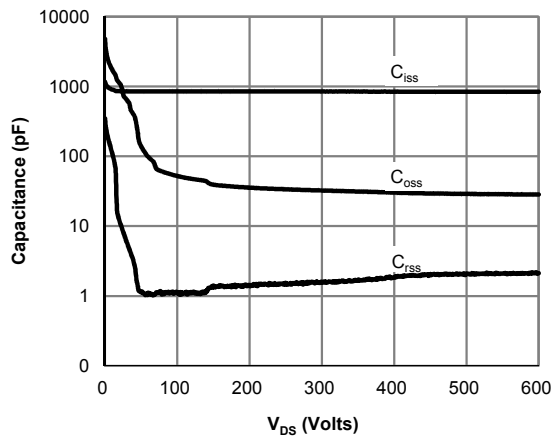


Figure 9: Capacitance Characteristics

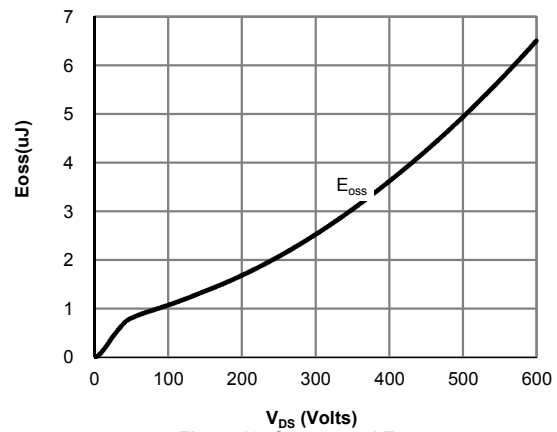


Figure 10: Coss stored Energy

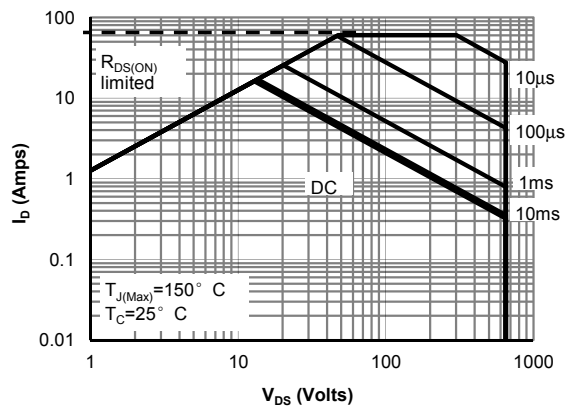


Figure 11: Maximum Forward Biased Safe Operating Area for AOT(B)15S65L (Note F)

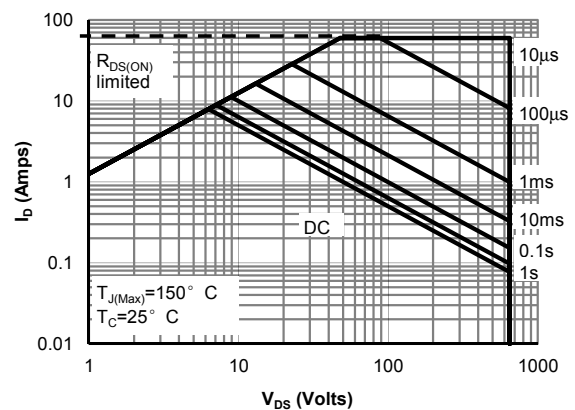
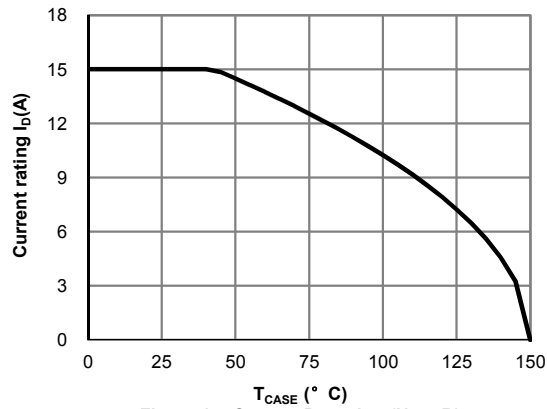
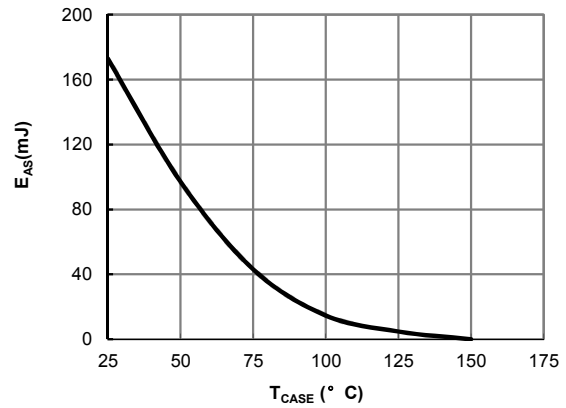
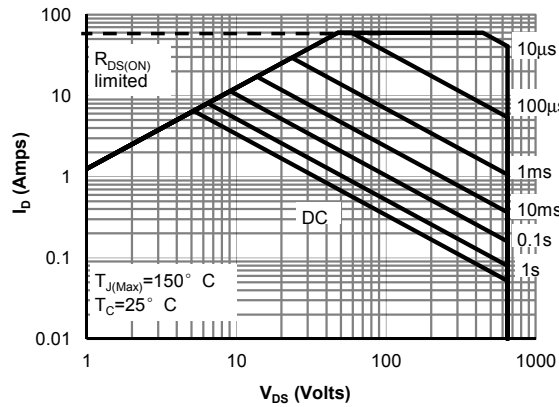


Figure 12: Maximum Forward Biased Safe Operating Area for AOTF15S65 (Note F)



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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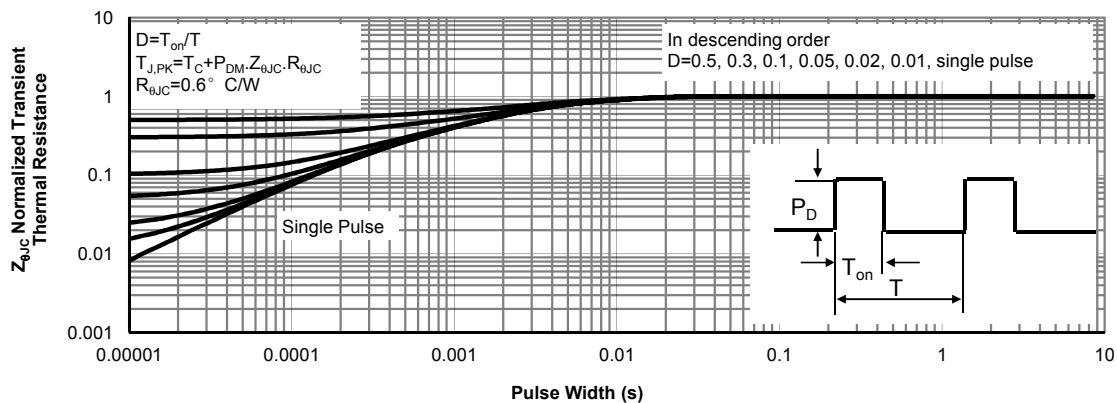


Figure 16: Normalized Maximum Transient Thermal Impedance for AOT(B)15S65L (Note F)

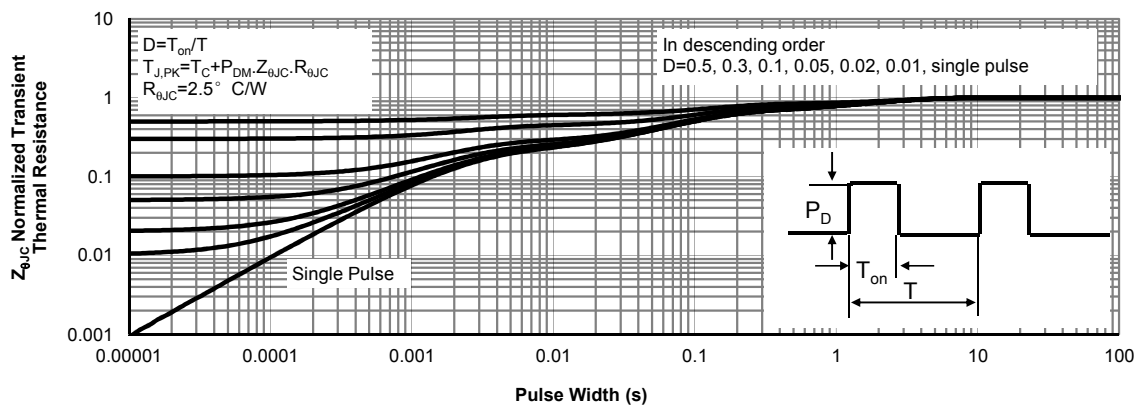


Figure 17: Normalized Maximum Transient Thermal Impedance for AOTF15S65 (Note F)

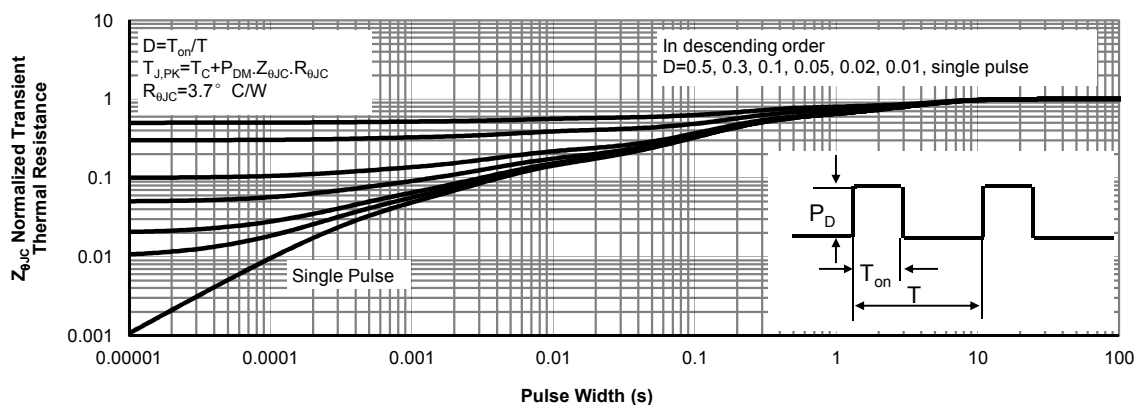
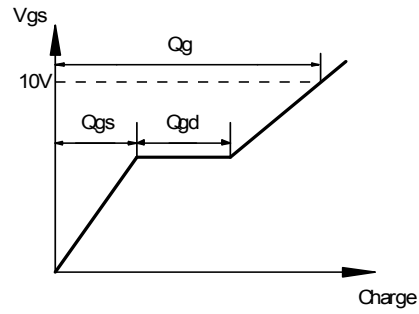
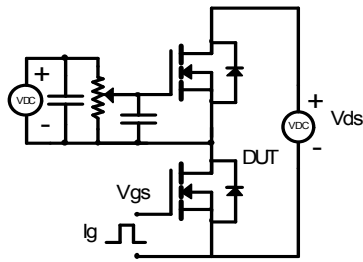
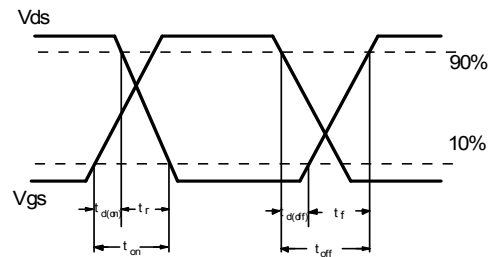
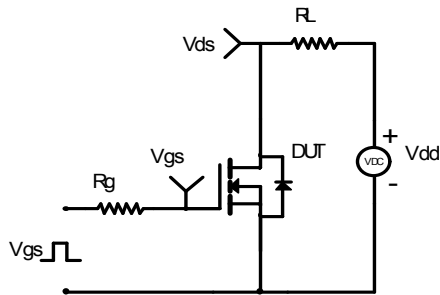


Figure 18: Normalized Maximum Transient Thermal Impedance for AOTF15S65L (Note F)

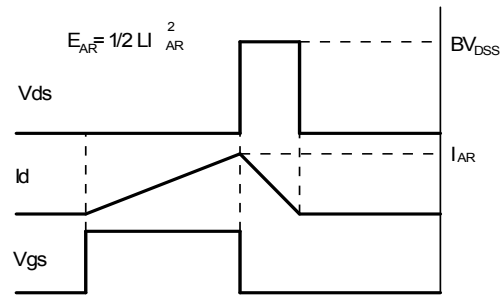
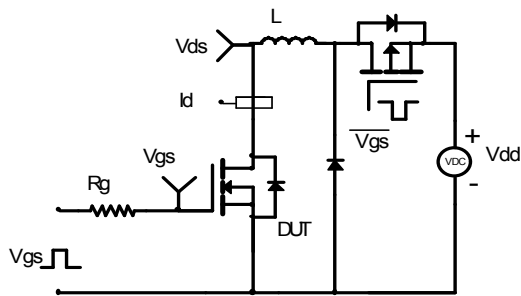
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

